## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10586682	LEYRER ET AL.
Examiner	Art Unit
HUI CHIN	4131

SEARCHED						
Class	Subclass	Date	Examiner			
524	543	10/9/2008	HC			
524	800	10/9/2008	HC			
524	459	10/9/2008	HC			
568	792	10/9/2008	HC			

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search	10/9/2008	HC
Inventor search on eDAN	10/9/2008	HC

	INTERFERENCE SEA	RCH	
Class	Subclass	Date	Examine
Class	Subciass	Date	Exam

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